FORM PTO-1449 (Colb)	ATTY DOCKET NO. 90648	SERIAL NUMBER 10/664,631
LIST OF PATENTS AND PUBLICATIONS FOR APPLICANTS' INFORMATION STATEMENT	APPLICANT Eran SHPAK, et al.	EXAMINER (N/A)
	FILING DATE	GROUP ART UNIT
	September 19, 2003	(N/A)

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